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PATENT NUMBER and  
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10028910	FILING DATE 12/28/2001	CLASS 435	SUBCLASS 6	GAU 1024	EXAMINER FORMAN 77141
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**\*\*APPLICANTS:** Nagasawa Hiroshi;

**\*\*CONTINUING DATA VERIFIED:**

**\*\* FOREIGN APPLICATIONS VERIFIED:**  
JAPAN 402451/2000 12/28/2000

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>
Foreign priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no		ATTORNEY DOCKET NO
35 USC 119 conditions met <input type="checkbox"/> yes <input type="checkbox"/> no		NAGASAWA=6
Verified and Acknowledged Examiners's initials		
TITLE : Affinity detecting/analytical chip, method for production thereof, detection method and detection system using same		

U.S. DEPT. OF COMM/PAT. 3 TM-PTO-436L/Rev. 12-94

<b>NOTICE OF ALLOWANCE MAILED</b>		<b>CLAIMS ALLOWED</b>	
		Total Claims	Print Claim for O.G
<b>ISSUE FEE</b>		<b>DRAWING</b>	
Amount Due	Date Paid	Sheets Drwg.	Figs. Drwg. Print Fig.
<input type="checkbox"/> <b>TERMINAL DISCLAIMER</b>		<b>Application Examiner</b>	
		<b>PREPARED FOR ISSUE</b>	
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